


<b>Search Notes</b>  	<b>Application/Control No.</b>  10817637	<b>Applicant(s)/Patent Under Reexamination</b>  IWATSU, TAKESHI
	<b>Examiner</b>  Ho, Binh V	<b>Art Unit</b>  2163

SEARCHED			
Class	Subclass	Date	Examiner
707	205	05/10/2007	BH

SEARCH NOTES		
Search Notes	Date	Examiner
707/205, 103R,3,6,9,204,203 East search (see printout)	05/10/2007	BH
707/205, 103R,3,6,9,204,203 (US Pub. East search)	07/24/2007	BH
East search (Inventor)	07/24/2007	BH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
707	103 R	07/24/2007	BH
707	205	07/24/2007	BH